Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination	
10605944	BOUDON ET AL.	
Examiner	Art Unit	
Wai, Eric C	2195	

	SEARCHED					
Class	Subclass	Date	Examiner			
718	100	07/09/2007	ECW			
365	221	12/14/2007	ECW			
711	144	6/4/2008	ECW			
370	545	6/4/2008	ECW			
326	38	12/3/2008	ECW			

SEARCH NOTES			
Search Notes	Date	Examiner	
Inventor's Name Search	07/09/2007	ECW	
East Search	07/09/2007	ECW	
Updated East Search	12/14/2007	ECW	
Google Scholar Search	12/14/2007	ECW	
Updated East Search	6/4/2008	ECW	
Updated East Search	12/03/2008	ECW	

INTERFERENCE SEARCH			
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